

Search Notes



Application/Control No.

10/707,712

Examiner

Jerome Jackson Jr.

Applicant(s)/Patent under
Reexamination

CHAN ET AL.

Art Unit

2815

SEARCHED

Class	Subclass	Date	Examiner
257	198	2/05	JJ

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
East: see inside	2/05	JJ
IEEE xlore: heterojunction size self-aligned	2/05	JJ